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INTERNATIONAL STANDARD

NORME INTERNATIONALE

Industrial non-destructive testing equipment P Electron linear accelerator

Appareils destinés aux essais non destructifs pour le secteur industriel – Accélérateur électronique linéaire

https://standards.iteh.ai/catalog/standards/sist/896ab927-340b-402f-b750f7091cf42c4a/iec-62976-2017





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Edition 1.0 2017-05

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Industrial non-destructive testing equipment P Electron linear accelerator (standards.iteh.ai) Appareils destinés aux essais non destructifs pour le secteur industriel – Accélérateur électronique linéaire_{IEC 62976:2017}

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INDUSTRIAL NON-DESTRUCTIVE TESTING EQUIPMENT – ELECTRON LINEAR ACCELERATOR

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The text of this standard is based on the following documents:

| FDIS | Report on voting |
|-------------|------------------|
| 45/821/FDIS | 45/824/RVD |

Full information on the voting for the approval of this standard can be found in the report on voting indicated in the above table.

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INDUSTRIAL NON-DESTRUCTIVE TESTING EQUIPMENT – ELECTRON LINEAR ACCELERATOR

1 Scope

This document gives the rules of naming, technical requirements, test methods, inspection, marking, packaging, transportation, storage and accompanying documents for electron linear accelerator equipment for Non-Destructive Testing (NDT).

This document applies to NDT electron linear accelerator equipment in the X-ray energy range of 1 MeV to 15 MeV, including the accelerator equipment for radiographic film, computed radiography with imaging plates, real-time imaging, digital detector array and industrial computerized tomography.

2 Normative references

The following documents are referred to in the text in such a way that some or all of their content constitutes requirements of this document. For dated references, only the edition cited applies. For undated references, the latest edition of the referenced document (including any amendments) applies to stand the standard prevent of the standard prevent standard prevents of the standard prevent standard prevents of the standard prevents of the standard prevent standard prevents of the standard prevent standard prevents of the standard prevents of the standard prevent standard prevent standard prevents of the standard prevent standard preve

ISO/IEC Guide 37:2012, Instructions for use of products by consumers

ISO 780:2015, *Packaging – Distribution <u>Packaging</u> – Graphical symbols for handling and storage of packages intps://standards.iteh.ai/catalog/standards/sist/896ab927-340b-402f-b750-*

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ISO 19232-1:2013, Non-destructive testing – Image quality of radiographs – Part 1: Determination of the image quality value using wire-type image quality indicators

3 Terms and definitions

For the purposes of this document, the following terms and definitions apply.

ISO and IEC maintain terminological databases for use in standardization at the following addresses:

- IEC Electropedia: available at http://www.electropedia.org/
- ISO Online browsing platform: available at http://www.iso.org/obp

3.1

target

area on the surface of accelerating tube outlet on which the electron beam impinges and from which the primary beam of X-rays is emitted

3.2

linear electron accelerator

LINAC

apparatus for producing high energy electrons by accelerating them along a waveguide. The electrons strike a target to produce X-rays

Note 1 to entry: NDT electron linear accelerator, hereinafter referred to as the accelerator.

3.3

X-rays

penetrating electromagnetic radiation, within the approximate wavelength range of 1 nm to 0,0001 nm, produced when high velocity electrons impinge on a metal target

[SOURCE: ISO 5576:1997, 2.129]

3.4

X-ray beam energy

Ε

maximum X-ray energy in the continuous emission spectrum, equal to the product of the electron charge and the accelerating voltage

Note 1 to entry: *E* is expressed in megaelectronvolts (MeV).

3.5

wedge X-ray field

X-radiation field with a dose distribution that changes approximately linearly with distance from the beam edge along a line perpendicular to and passing through the radiation beam axis

[SOURCE: IEC 60976, 2007, 3.32]

3.6

half-value layer iTeh STANDARD PREVIEW

thickness of a specified material, which attenuates under narrow beam conditions X- radiation with a particular spectrum to (an extent such that the air) kerma rate, exposure rate or absorbed dose rate is reduced to one half of the value that is measured without the material. The half-value layer (HVL) is expressed in suitable submultiples of the metre together with the material

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f7091cf42c4a/iec-62976-2017

[SOURCE: IEC 60601-1-3, 2008, 3.27]

3.7

X-ray beam focal spot

d

dimension across the focal spot of an accelerating tube, measured perpendicular to the central beam axis

Note 1 to entry: *d* is expressed in millimetres (mm).

3.8

X-ray beam homogeneity

ratio, expressed as a percent, of the dose rate in a plane 1 m from the target and normal to the beam central axis, and acquired at a specified angle from the central axis, to the dose rate in the plane and on the beam axis

3.9

X-ray beam air kerma rate

Κ

volume of ionization caused by the x-ray beam in air per unit time at 1 m away from target

Note 1 to entry: *K* is expressed in centigrays per minute (cGy/min).

3.10

X-ray beam asymmetry

ratio of the difference to the average values of the dose rates measured at equal distances from the central beam axis and in a vertical plane normal to the x-ray beam

Note 1 to entry: This ratio is expressed as a percentage.

3.11

X-ray sensitivity

ratio of the minimum defect size that can be observed in the detector to the thickness of the penetrated material

Note 1 to entry: This ratio is expressed as a percentage.

3.12

X-ray head

part of an X-ray installation that contains the accelerating tube and its shield

Equipment sets, names and work conditions 4

4.1 **Equipment sets**

Generally, the equipment consists of the following components:

- a) X-ray head,
- b) modulator,
- c) temperature control unit (TCU),
- d) control system,
- e) power distribution cabinet, STANDARD PREVIEW
- f) safety interlock system,
- (standards.iteh.ai) g) interconnecting cables (X-ray head to modulator, modulator to console) and hoses (TCU to X-ray head). IEC 62976:2017
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The naming rules of the equipment are shown in Figure 1.



Figure 1 – Naming convention

The specifications of several commonly used accelerator models are shown in Table 1.

| | Specification | | |
|-------------|-------------------|-------------------------|--|
| Model No. | X-ray beam energy | Maximum X-ray dose rate | |
| | MeV | cGy/min | |
| XX-2/200 | 2 | 200 | |
| XX-4/500 | 4 | 500 | |
| XX-6/1000 | 6 | 1 000 | |
| XX-9/3000 | 9 | 3 000 | |
| XX-12/5000 | 12 | 5 000 | |
| XX-15/12000 | 15 | 12 000 | |

Table 1 – Specifications of several commonly used accelerator models

4.3 **Operating conditions**

4.3.1 Environmental requirement

Technical requirements

- environment temperature: (5 to 40) °C;
- relative humidity: ≤90 %.

4.3.2 Power supply

- voltage: 380 V \pm 10 % three-phase four-wire AC system; EVIEW
- frequency: 50 Hz ±2 % / 60 Hz ±a%dards.iteh.ai)
- power supply: it is put forward in the product manual according to the accelerator model;
- grounding resistance: special grounding resistance of modulator is less than 4 Ω. https://standards.iteh.ai/catalog/standards/sist/896ab927-340b-402f-b750-

f7091cf42c4a/iec-62976-2017

5.1 Appearance

5

The surface shall be smooth, uniform color, no obvious scratches, bumps or holes.

5.2 Control system

5.2.1 Design principle

The design of the control system shall ensure the safety of the operator, the device and the delivered dose.

5.2.2 Operation of start and stop

Operation of X-ray source start and stop shall be executed in the control console.

5.2.3 Functions of control system

The basic functions of the control system shall include:

- normal start-up and shut-down,
- display of the status of normal, fault, alarm and auto-stop,
- display of the main operational parameters,
- safety interlock,
- emergency stop.

5.3 Performance

5.3.1 X-ray beam energy

Commonly used X-ray beam energies of accelerators are shown in Table 2 and the corresponding half value layer should not be less than the value in Table 2.

| X-ray beam energy | Steel (Material density: 7,8 × 10 ³ kg/m ³) | Plexiglas (Material density:1,7 × 10 ³ kg/m ³) |
|-------------------|---|--|
| MeV | mm | mm |
| 1 | 16 ± 0,5 | 61 ± 2 |
| 2 | 20 ± 0,5 | 84 ± 2 |
| 4 | 25 ± 0,5 | 116 ± 2 |
| 6 | 28 ± 0,5 | 138 ± 2 |
| 9 | 30 ± 0,5 | 149 ± 2 |
| 12 | 32 ± 0,5 | 178 ± 2 |
| 15 | 33 ± 0,5 | 204 ± 2 |

Table 2 – Half value layer of materials corresponding to commonly used X-ray beam energies

5.3.2 X-ray homogeneity STANDARD PREVIEW

X-ray homogeneity shall not be less than the value in Table 3 by using a beam flattening filter.

Table 3 – X-ray homogeneity of commonly used X-ray beam energies

| X-ray beam energy | https://standards.itch.ai/catalog/standards/sist/896ab927-340b-402f-b750- Subtended angle <i>A</i> between beam central axis, and axis connecting the centre of focal spot with the point of measurement located on the circumference | X-ray homogeneity |
|----------------------|--|----------------------|
| MeV | (°) | % |
| 1 | 7,5 | 80 |
| 2 | 7,5 | 78 |
| 4 | 7,5 | 75 |
| 6 | 7,5 | 62 |
| 9 | 7,5 | 55 |
| 12 | 6,0 | 50 |
| 15 | 6,0 | 45 |

5.3.3 X-ray beam air kerma rate

X-ray beam air kerma rate shall achieve the value shown in Table 4 (can be reduced based on purpose).

| X-ray beam energy | X-ray beam dose rate |
|-------------------|----------------------|
| MeV | cGy/min |
| 1 | 20 |
| 2 | 200 |
| 4 | 500 |
| 6 | 1 000 |
| 9 | 3 000 |
| 12 | 5 000 |
| 15 | 12 000 |

Table 4 – X-ray beam air kerma rate of different models

5.3.4 X-ray beam focal spot

The diameter of the X-ray spot shall be less than or equal to 2,0 mm when the X-ray beam energy is less than 9 MeV; the diameter of X-ray spot shall be less than or equal to 3,5 mm when X-ray beam energy is equal to or higher than 9 MeV.

5.3.5 X-ray beam asymmetry

X-ray beam asymmetry shall be less than 3 % at 7.5° away from X-ray beam center axis when the X-ray beam energy is less than or equal to 9 MeV; X-ray beam asymmetry shall be less than 5 % at 6° away from X-ray beam center axis when X-ray beam energy is higher than (standards.iteh.ai) 9 MeV.

5.3.6 X-ray sensitivity IEC 62976:2017

https://standards.iteh.ai/catalog/standards/sist/896ab927-340b-402f-b750-In the range of the X-ray beam energy_andicthe_ocorresponding equivalent steel thickness stated in Table 5, X-ray sensitivity shall be less than 1 % as determined by linear densitometry for imaging detection.

| X-ray beam energy | Range of equivalent steel thickness |
|---|--|
| MeV | mm |
| 1 | 36 to 150 |
| 2 | 40 to 200 |
| 4 | 50 to 250 |
| 6 | 50 to 280 |
| 9 | 76 to 380 |
| 12 | 100 to 420 |
| 15 | 100 to 460 |
| NOTE Equivalent steel thickness is the conversion | of different plate thickness based on the density of |

Table 5 – Detection range of equivalent steel thickness corresponding to commonly used X-ray beam energies

7,8 x 10³ kg/m³ steel.

5.3.7 Dose leakage

a) X-ray dose leakage

A measure of leakage is given by the ratio of X-ray dose rate 1 m away from the target in a variety of directions to the X-ray dose rate on the central beam axis. This shall be expressed as a percentage and shall be less than 0,1 %.

b) Neutron dose leakage (if the accelerator energy is higher than or equal to 10 MeV)

Neutron dose rate shall be no more than 0,01 mSv/h 1 m away from the target beyond the X-ray field formed by the forward collimator and no more than 0,001 mSv/h in other places.

5.4 Electrical safety

5.4.1 Protective grounding

Separated electric shock protection is essential. The resistance between metal surface and grounding terminal shall not be more than 0,1 Ω .

5.4.2 Insulation resistance

The insulation resistance between wires (including phase line and zero line) and ground of each independent electrical part of the equipment should not be less than 1 M Ω when the test voltage (AC RMS or DC average) reaches to 1 000 V.

5.4.3 Dielectric strength

Electrical equipment with electrical grounding should tolerate the dielectric strength testing of

2 000 V (AC RMS or DC average) with no breakdown and no repeated arcing during the test.

5.4.4 Protection against electric shock IEC 62976:2017

Electrical equipments of a the accelerator should in a verbanti 3 shock functionality under the condition of normal use, the touchable parts should not be hazardous or live. The voltage between accessible component and ground terminal should be less than AC 30 V or DC 60 V. The warning symbols for "high voltage" shall be posted near the high voltage device.

5.5 Reliability

5.5.1 Continuous operation

The device shall be able to operate for 8 h with less than 4 interruptions lasting no more than 30 min each.

5.5.2 Recovery

The time of reaching the normal work status shall be less than 15 min when the downtime without fault is longer than 1 h after shutdown.

5.5.3 Restart

The time of reaching the normal work status shall be less than 150 min when the downtime without fault is longer than 48 h after shutdown.

6 Test methods

6.1 General requirements

6.1.1 Testing conditions

The test shall be carried out under the conditions of Table 6.

| Environmental parameter | Reference value | Range |
|---------------------------------|-----------------|---------------------------|
| Temperature | 25 °C | 5 °C to 40 °C |
| Relative humidity | 65 % | ≤90 % |
| Atmospheric pressure | 101,3 kPa | 86 kPa to 106 kPa |
| Voltage (alternating current) | 380 V | 380 V ± 10 % |
| Frequency (alternating current) | 50 Hz /60 Hz | 50 Hz ± 2 % / 60 Hz ± 2 % |

Table 6 – Testing conditions

6.1.2 Instruments and devices

6.1.2.1 General

Within the validity verification, the test equipment and instruments should meet the test requirements.

6.1.2.2 X-ray dose meter

An X-ray dose meter is used to measure the in-beam air kerma rate.

6.1.2.3 Wire-type image quality indicators

Wire-type image quality cindicators complying with ISO 19232-1:2013 shall be used to measure X-ray sensitivity.

(standards.iteh.ai)

6.1.2.4 "Sandwich" test module

IEC 62976:2017

The "Sandwich" test module is used to measure the X-ray beam focal spot size. It is closely superposed by the rectangular (250 mm x 60 mm) copper or lead foil (with white color) and plastic pieces (with black color) alternately as shown in Figure 2, the foil thickness h1 is not more than 0,1 mm, plastic film thickness h2 is not more than 0,3 mm, and the superimposing thickness is not less than 60 mm.

Dimensions in millimetres



Figure 2 – Sketch map of the test module

6.1.2.5 Copper block with a swivelling edge

The copper block (60 mm x 60 mm x 16 mm) with a swiveling edge \pm 15° is a test block using as alternative method for the focal spot measurement, see Figure 3.